## Applicant(s)/Patent Under Application/Control No. Reexamination 10/690,697 KUZUHARA ET AL Notice of References Cited Art Unit Examiner Page 1 of 1 2826 A. Sefer **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2004/0233363 11-2004 Murayama et al. 349/117 Α В US-Ç US-D US-Ε US-US-F US-G US-Н ı US-US-US-US-US-М FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Classification Name Country MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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